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July 1988 Revised August 2000

100325

Low Power Hex ECL-to-TTL Translator

General Description

The 100325 is a hex translator for converting F100K logic levels to TTL logic levels. Differential inputs allow each circuit to be used as an inverting, non-inverting or differential receiver. An internal reference voltage generator provides V_{BB} for single-ended operation, or for use in Schmitt trigger applications. All inputs have $50 k\Omega$ pull-down resistors. When the inputs are either unconnected or at the same potential the outputs will go LOW.

When used in single-ended operation the apparent input threshold of the true inputs is 20mV to 40mV higher (positive) than the threshold of the complementary inputs. The V_{EE} and V_{TTL} power may be applied in either order.

Features

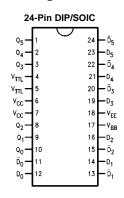
- Pin/function compatible with 100125
- Meets 100125 AC specifications
- 50% power reduction of the 100125
- Differential inputs with built in offset
- Standard FAST® outputs
- 2000V ESD protection
- -4.2V to -5.7V operating range
- Available to industrial grade temperature range

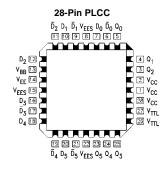
Ordering Code:

Order Number	Package Number	Package Description
100325SC	M24B	24-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300 Wide
100325PC	N24E	24-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-010, 0.400 Wide
100325QI	V28A	28-Lead Plastic Lead Chip Carrier (PLCC), JEDEC MO-047, 0.450 Square
100325QC	V28A	28-Lead Plastic Lead Chip Carrier (PLCC), JEDEC MO-047, 0.450 Square Industrial Temperature Range (–40°C to +85°C)

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

Connection Diagrams





Pin Descriptions

Pin Names	Description
D ₀ -D ₅	Data Inputs
I – –	Inverting Data Inputs
Q ₀ -Q ₅	Data Outputs

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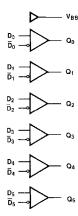
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Truth Table

Inp	uts	Outputs
D _n	\overline{D}_n	Q _n
L	Н	L
Н	L	Н
L	L	L
Н	Н	L
OPEN	OPEN	L
V_{EE}	V_{EE}	L
L	V_{BB}	L
Н	V_{BB}	Н
V_{BB}	L	Н
V _{BB} V _{BB}	Н	L

H = HIGH Voltage Level L = LOW Voltage Level

Logic Diagram



Absolute Maximum Ratings(Note 1)

Recommended Operating Conditions -65°C to +150°C

Storage Temperature (T_{STG}) Maximum Junction Temperature (T_J)

+150°C Case Temperature (T_C)

V_{EE} Pin Potential to Ground Pin

-7.0V to +0.5V

Commercial Industrial

0°C to +85°C

V_{TTL} Pin Potential to Ground Pin Input Voltage (DC)

-0.5V to +6.0V V_{EE} to +0.5V Supply Voltage (V_{EE}) -40°C to +85°C -5.7V to -4.2V

Voltage Applied to Output

in HIGH State (with $V_{CC} = 0V$)

Current Applied to Output in LOW State (Max)

ESD (Note 2)

 $-0.5 V \ to \ V_{CC}$. Note 1: The "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. The device should not be operated at these limits. The parametric values defined in the Electrical twice the rated I_{OL} (mA) Characteristics tables are not guaranteed at the absolute maximum rating. The "Recommended Operating Conditions" table will define the conditions ≥2000V for actual device operation.

Note 2: ESD testing conforms to MIL-STD-883, Method 3015.

Commercial Version

DC Electrical Characteristics

 $\rm V_{EE} = -4.2V$ to $-5.7V,~V_{CC} = GND,~V_{TTL} = +4.5V$ to $5.5V,~T_C = 0^{\circ}C$ to $+85^{\circ}C$ (Note 3)

Symbol	Parameter	Min	Тур	Max	Units	Conditions	
V _{BB}	Output Reference Voltage	-1380	-1320	-1260	mV	I _{VBB} = -2.1 mA	
V _{IH}	Single-Ended Input HIGH Voltage	-1165		-870	mV	Guaranteed HIGH Signal for All Inputs (with One Input Tied to V _{BB})	
V _{IL}	Single-Ended Input LOW Voltage	-1830		-1475	mV	Guaranteed LOW Signal for All Inputs (with One Input Tied to V _{BB})	
V _{OH}	Output HIGH Voltage	2.5			V	$I_{OH} = -2.0 \text{ mA}$	$V_{IN} = V_{IH (Max)}$
V _{OL}	Output LOW Voltage			0.5	V	I _{OL} = 20 mA	or V _{IL (Min)}
V _{DIFF}	Input Voltage Differential	150			mV	Required for Full Output Swing	
V _{CM}	Common Mode Voltage	V _{CC} – 2.0		V _{CC} - 0.5	V		
I _{IH}	Input HIGH Current			350	μА	$ \begin{aligned} & V_{IN} = V_{IH~(Max)}, ~ D_0 - D_5 = V_{BB}, \\ & \overline{D}_0 - \overline{D}_5 = V_{IL~(Min)} \end{aligned} $	
I _{IL}	Input LOW Current	0.5			μΑ	$V_{IN} = V_{IL (Min)}, D_0 - D_5 = V_{BB}$	
Ios	Output Short-Circuit Current	-150		-60	mA	V _{OUT} = GND (Note 4)	
I _{EE}	V _{EE} Power Supply Current	-37	-27	-17	mA	$D_0 - D_5 = V_{BB}$	
I _{TTL}	V _{TTL} Power Supply Current		45	65	mA	$D_0 - D_5 = V_{BB}$	

Note 3: The specified limits represent the "worst case" value for the parameter. Since these values normally occur at the temperature extremes, additional noise immunity and guardbanding can be achieved by decreasing the allowable system operating ranges. Conditions for testing shown in the tables are chosen to guarantee operation under "worst case" conditions.

Note 4: Test one output at a time.

DIP AC Electrical Characteristics

 $\mbox{V}_{EE} = -4.2\mbox{V}$ to $-5.7\mbox{V}, \mbox{ } \mbox{V}_{CC} = \mbox{GND}, \mbox{ } \mbox{V}_{TTL} = +4.5\mbox{V}$ to $+5.5\mbox{V}$

Symbol	Parameter	$T_C = 0$ °C		$T_C = +25^{\circ}C$		T _C = +85°C		Units	Conditions
Syllibol	Farameter	Min	Max	Min	Max	Min	Max	Oilles	Conditions
t _{PLH}	Propagation Delay	0.80	3.50	0.90	3.70	1.00	4.00	ns	C _L = 15 pF
t _{PHL}	Data to Output	0.80	3.50	0.90	3.70	1.00	4.00	115	Figures 1, 2
t _{PLH}	Propagation Delay	1.60	4.30	1.70	4.50	1.80	4.80	ns	C _L = 50 pF
t _{PHL}	Data to Output	1.00	4.30	1.70	4.50	1.00	4.00	115	Figures 1, 3

Commercial Version (Continued) SOIC and PLCC AC Electrical Characteristics

 $V_{EE} = -4.2 V$ to -5.7 V, $V_{CC} = GND$, $V_{TTL} = +4.5 V$ to +5.5 V

Symbol	Parameter	$T_C = 0$ °C		$T_C = +25^{\circ}C$		$T_C = +85^{\circ}C$		Units	Conditions
		Min	Max	Min	Max	Min	Max	•	Conditions
t _{PLH}	Propagation Delay	0.80	3.30	0.90	3.50	1.00	3.80	ns	C _L = 15 pF
t _{PHL}	Data to Output	0.60	3.30	0.90	3.30	1.00	3.00	115	Figures 1, 2
t _{PLH}	Propagation Delay	1.60	4.10	1.70	4.30	1.80	4.60	no	C _L = 50 pF
t _{PHL}	Data to Output	1.60	4.10	1.70	4.30	1.80	4.00	ns	Figures 1, 3
t _{OSHL}	Maximum Skew Common Edge								PLCC Only
	Output-to-Output Variation		0.65		0.65		0.65	ns	(Note 5)
	Data to Output Path								
t _{OSLH}	Maximum Skew Common Edge								PLCC Only
	Output-to-Output Variation		0.65		0.65		0.65	ns	(Note 5)
	Data to Output Path								
t _{OST}	Maximum Skew Opposite Edge								PLCC Only
	Output-to-Output Variation		2.20		2.20		2.20	ns	(Note 5)
	Data to Output Path								
t _{PS}	Maximum Skew								PLCC Only
	Pin (Signal) Transition Variation		2.10		2.10		2.10	ns	(Note 5)
	Data to Output Path								

Note 5: Output-to-Output Skew is defined as the absolute value of the difference between the actual propagation delay for any outputs within the same packaged device. The specifications apply to any outputs switching in the same direction either HIGH-to-LOW (t_{OSHL}), or LOW-to-HIGH (t_{OSLH}), or in opposite directions both HL and LH (t_{OST}). Parameters t_{OST} and t_{PS} guaranteed by design.

Industrial Version

PLCC DC Electrical Characteristics

 $V_{EE} = -4.2 V$ to -5.7 V, $V_{CC} = GND$, $T_C = -40 ^{\circ} C$ to $+85 ^{\circ} C$ (Note 6)

Symbol	Parameter	T _C = -	-40°C	T _C = 0°C	to +85°C	Units	Conditions		
Symbol	Farameter	Min	Max	Min	Max	Units	Conditions		
V _{BB}	Output Reference Voltage	-1395	-1255	-1380	-1260	mV	I _{VBB} = -2.1 mA		
V _{IH}	Single-Ended Input	-1170	-870	-1165	-870	mV	Guaranteed HIGH Signal for All Inputs		
	HIGH Voltage	-1170	-070	-1103	-670	IIIV	(with One Input Tied to V _{BB})		
V _{IL}	Single-Ended Input	-1830	-1480	-1830	-1475	mV	Guaranteed LOW Signal for All Inputs		
	LOW Voltage	-1000	-1400	-1000	-1475	1111	(with One Input Tied to V _{BB})		
V _{OH}	Output HIGH Voltage	2.5		2.5		V	$I_{OH} = -2.0 \text{ mA}$ $V_{IN} = V_{IH \text{ (Max)}}$		
V _{OL}	Output LOW Voltage		0.5		0.5	V	$I_{OL} = 20 \text{ mA}$ or $V_{IL \text{ (Min)}}$		
V_{DIFF}	Input Voltage Differential	150		150		mV	Required for Full Output Swing		
V _{CM}	Common Mode Voltage	V _{CC} – 2.0	V _{CC} - 0.5	V _{CC} – 2.0	V _{CC} – 0.5	V			
I _{IH}	Input HIGH Current		450		350	μΑ	$V_{IN} = V_{IH \text{ (Max)}}, D_0 - D_5 = V_{BB},$		
							$\overline{D}_0 - \overline{D}_5 = V_{IL \text{ (Min)}}$		
I _{IL}	Input LOW Current	0.5		0.5		μΑ	$V_{IN} = V_{IL (Min)}, D_0 - D_5 = V_{BB}$		
I _{OS}	Output Short-Circuit Current	-150	-60	-150	-60	mA	V _{OUT} = GND (Note 7)		
I _{EE}	V _{EE} Power Supply Current	-37	-15	-37	-17	mA	$D_0 - D_5 = V_{BB}$		
I _{TTL}	V _{TTL} Power Supply Current		65		65	mA	$D_0 - D_5 = V_{BB}$		

Note 6: The specified limits represent the "worst case" value for the parameter. Since these values normally occur at the temperature extremes, additional noise immunity and guardbanding can be achieved by decreasing the allowable system operating ranges. Conditions for testing shown in the tables are chosen to guarantee operation under "worst case" conditions.

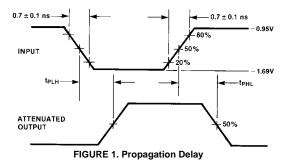
Note 7: Test one output at a time.

PLCC AC Electrical Characteristics

 $V_{EE} = -4.2V$ to -5.7V, $V_{CC} = GND$, $V_{TTL} = +4.5V$ to +5.5V

Symbol	Parameter	T _C = -40°C		$T_C = +25^{\circ}C$		T _C = +85°C		Units	Conditions		
		Min	Max	Min	Max	Min	Max	Oilita	Conditions		
t _{PLH}	Propagation Delay	0.80	3.30	0.90	3.50	1.00	3.80	ns	C _L = 15 pF		
t _{PHL}	Data to Output	0.60	0.60 3.30	0.90	3.30	1.00	3.60	115	Figures 1, 2		
t _{PLH}	Propagation Delay	1.60	4.10	1.70	4.20	4.30	4.20	1.80	4.60	ns	C _L = 50 pF
t _{PHL}	Data to Output	1.00	4.10	1.70	4.30	1.00	4.00	115	Figures 1, 3		

Switching Waveform

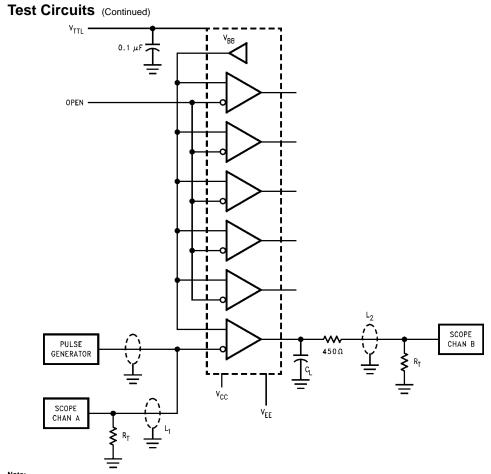




Test Circuits OPEN -280Ω PULSE GENERATOR SCOPE CHAN A SCOPE CHAN B

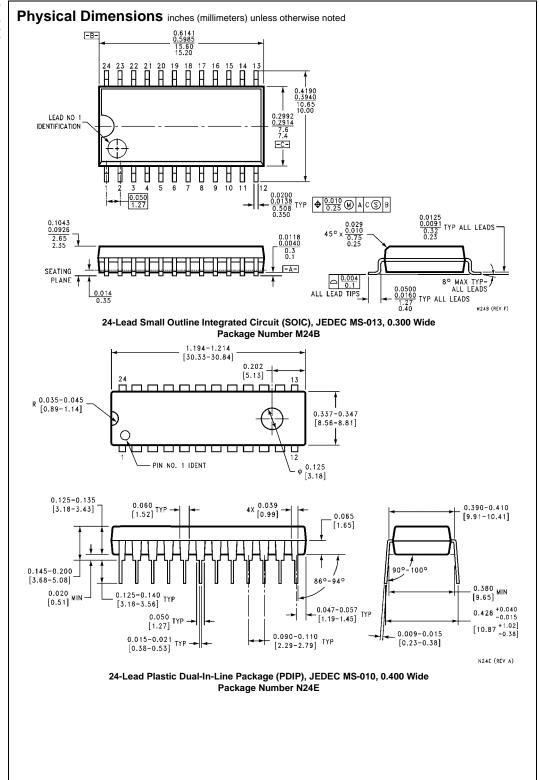
- $\bullet \quad \ \ V_{CC}=0V,\,V_{EE}=-4.5V,\,V_{TTL}=+5V$
- L1 and L2 = equal length 50Ω impedance lines
- $R_T = 50\Omega$ terminator internal to scope
- Decoupling 0.1 μF from GND to $V_{CC},\,V_{EE}$ and V_{TTL}
- All unused outputs are loaded with 500Ω to GND
- C_L = Fixture and stray capacitance = 15 pF

FIGURE 2. AC Test Circuit for 15 pF Loading

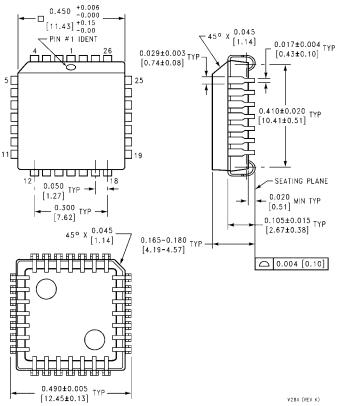


- $V_{CC} = 0V$, $V_{EE} = -4.5V$, $V_{TTL} = +5V$
- L1 and L2 = equal length 50Ω impedance lines
- $R_T = 50\Omega$ terminator internal to scope
- Decoupling 0.1 μF from GND to $V_{CC},\,V_{EE}$ and V_{TTL}
- All unused outputs are loaded with 500 $\!\Omega$ to GND
- $C_L = Fixture$ and stray capacitance = 50 pF

FIGURE 3. AC Test Circuit for 50 pF Loading



Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



28-Lead Plastic Lead Chip Carrier (PLCC), JEDEC MO-047, 0.450 Square Package Number V28A

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